

October 2000 **PRELIMINARY** 

# **FDG6308P**

# P-Channel 1.8V Specified PowerTrench® MOSFET

### **General Description**

This P-Channel 1.8V specified MOSFET uses Fairchild's advanced low voltage PowerTrench process. It has been optimized for battery power management applications.

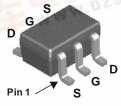
## **Applications**

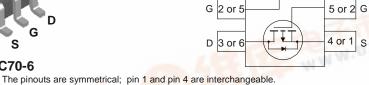
- Battery management
- · Load switch

## **Features**

- -0.6 A, -20 V.  $R_{DS(ON)} = 0.40 \Omega$  @  $V_{GS} = -4.5 V$  $R_{DS(ON)} = 0.55 \Omega @ V_{GS} = -2.5 V$  $R_{DS(ON)} = 0.80 \Omega @ V_{GS} = -1.8 V$
- Low gate charge
- High performance trench technology for extremely low R<sub>DS(ON)</sub>
- Compact industry standard SC70-6 surface mount package

6 or 3 D





S 1 or 4

Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
$V_{DSS}$	Drain-Source Voltage		-20	V
V <sub>GSS</sub>	Gate-Source Voltage		± 8	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1)	-0.6	Α
	- Pulsed	-	-1.8	101
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1)	0.3	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		−55 to +150	°C

### Thermal Characteristics

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$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1)	415	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
.08	FDG6308P	7"	8mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics		I.		l .	
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = -250 \mu\text{A}$	-20			V
<u>ΔBV<sub>DSS</sub></u> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu\text{A}$ , Referenced to 25°C		-15		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -16 \text{ V},  V_{GS} = 0 \text{ V}$			-1	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	$V_{GS} = -8 \text{ V},  V_{DS} = 0 \text{ V}$			-100	nA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = 8 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
On Char	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = -250 \mu\text{A}$	-0.4	-0.9	-1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu A$ , Referenced to 25°C		2		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$\begin{split} V_{GS} = -4.5 &\text{ V}, \text{ I}_D = -0.6 \text{ A} \\ V_{GS} = -2.5 &\text{ V}, \text{ I}_D = -0.5 \text{ A} \\ V_{GS} = -1.8 &\text{ V}, \text{ I}_D = -0.4 \text{ A} \\ V_{GS} = -4.5 &\text{ V}, \text{ I}_D = -0.6 \text{ A}, \text{ T}_J = 125 ^{\circ}\text{C} \end{split}$		0.27 0.36 0.55 0.35	0.40 0.55 0.80 0.56	Ω
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$	-2			Α
<b>g</b> <sub>FS</sub>	Forward Transconductance	$V_{DS} = -5 \text{ V},  I_{D} = -0.6 \text{ A}$		2.1		S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -10 \text{ V},  V_{GS} = 0 \text{ V},$		153		pF
Coss	Output Capacitance	f = 1.0 MHz		25		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			9		pF
Switchin	g Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = -10 \text{ V},  I_D = 1 \text{ A},$		5	10	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$		15	27	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			7	14	ns
t <sub>f</sub>	Turn-Off Fall Time			1.6	3.2	ns
$Q_g$	Total Gate Charge	$V_{DS} = -10 \text{ V}, I_{D} = -0.6 \text{ A},$		1.8	2.5	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = -4.5 \text{ V}$		0.3		nC
$Q_{gd}$	Gate-Drain Charge			0.4		nC
Drain-Sc	ource Diode Characteristics					
Is	Maximum Continuous Drain-Sour	ce Diode Forward Current			-0.25	Α
$V_{SD}$	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{S} = -0.25 \text{ A}(\text{Note 2})$		-0.77	-1.2	V

#### Notes

<sup>1.</sup>  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.  $R_{\theta JA} = 415^{\circ} \text{C/W}$  when mounted on a minimum pad.

**<sup>2.</sup>** Pulse Test: Pulse Width <  $300\mu s$ , Duty Cycle < 2.0%

## **Typical Characteristics**

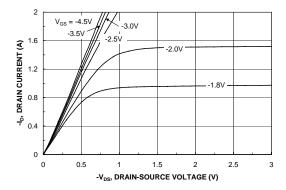


Figure 1. On-Region Characteristics.

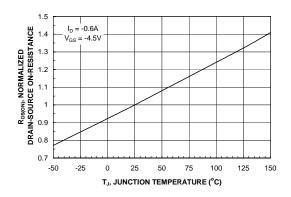


Figure 3. On-Resistance Variation with Temperature.

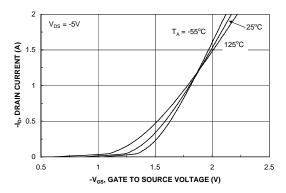


Figure 5. Transfer Characteristics.

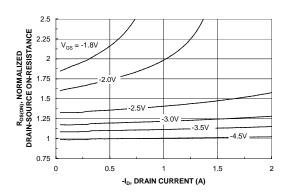


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

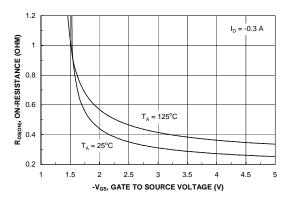


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

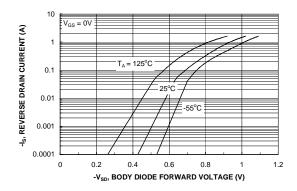
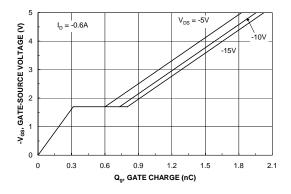


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## **Typical Characteristics**



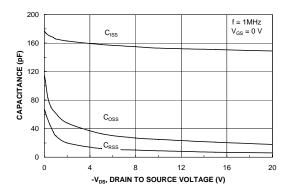


Figure 7. Gate Charge Characteristics.

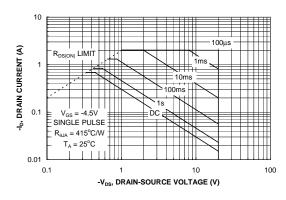


Figure 8. Capacitance Characteristics.

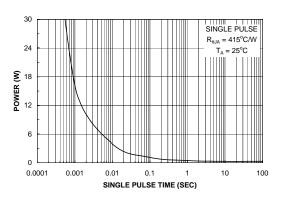


Figure 9. Maximum Safe Operating Area.



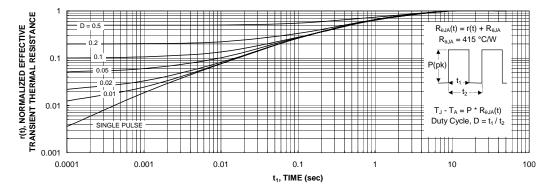


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1. Transient thermal response will change depending on the circuit board design.

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